

# NID9N05CL, NID9N05ACL

## Power MOSFET

9.0 A, 52 V, N-Channel, Logic Level, Clamped MOSFET w/ESD Protection in a DPAK Package



ON Semiconductor®

<http://onsemi.com>

### Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

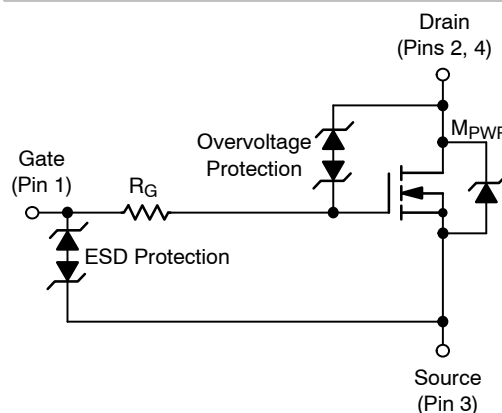
### Features

- Diode Clamp Between Gate and Source
- ESD Protection – HBM 5000 V
- Active Over-Voltage Gate to Drain Clamp
- Scalable to Lower or Higher  $R_{DS(on)}$
- Internal Series Gate Resistance
- Pb-Free Packages are Available

### Applications

- Automotive and Industrial Markets:  
Solenoid Drivers, Lamp Drivers, Small Motor Drivers

$V_{DSS}$ (Clamped)	$R_{DS(ON)}$ TYP	$I_D$ MAX (Limited)
52 V	90 mΩ	9.0 A



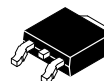
### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	$V_{DSS}$	52–59	V
Gate-to-Source Voltage – Continuous	$V_{GS}$	±15	V
Drain Current – Continuous @ $T_A = 25^\circ\text{C}$ – Single Pulse ( $t_p = 10 \mu\text{s}$ )	$I_D$ $I_{DM}$	9.0 35	A
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	$P_D$	1.74	W
Operating and Storage Temperature Range	$T_J, T_{stg}$	–55 to 175	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 125^\circ\text{C}$ ( $V_{DD} = 50 \text{ V}$ , $I_{D(pk)} = 1.5 \text{ A}$ , $V_{GS} = 10 \text{ V}$ , $R_G = 25 \Omega$ )	$E_{AS}$	160	mJ
Thermal Resistance, Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	$R_{\theta JC}$ $R_{\theta JA}$ $R_{\theta JA}$	5.2 72 100	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 seconds	$T_L$	260	$^\circ\text{C}$

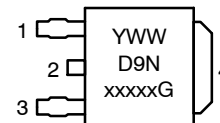
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in<sup>2</sup>).
2. When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in<sup>2</sup>).

### MARKING DIAGRAM



DPAK  
CASE 369C  
STYLE 2



Y	= Year	1	= Gate
WW	= Work Week	2	= Drain
xxxxx	= 05CL or 05ACL	3	= Source
G	= Pb-Free Package	4	= Drain

### ORDERING INFORMATION

Device	Package	Shipping†
NID9N05CLT4	DPAK	2500/Tape & Reel
NID9N05CLT4G	DPAK (Pb-Free)	
NID9N05ACLT4G	DPAK (Pb-Free)	75 Units/Rail
NID9N05CL	DPAK	
NID9N05CLG	DPAK (Pb-Free)	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# NID9N05CL, NID9N05ACL

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (Note 3) (V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1.0 mA, T <sub>J</sub> = 25°C) (V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1.0 mA, T <sub>J</sub> = -40°C to 125°C) Temperature Coefficient (Negative)	V <sub>(BR)DSS</sub>	52 50.8 -	55 54 -10	59 59.5 -	V V mV/°C
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V) (V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C)	I <sub>DSS</sub>	- -	- -	10 25	μA
Gate-Body Leakage Current (V <sub>GS</sub> = ±8 V, V <sub>DS</sub> = 0 V) (V <sub>GS</sub> = ±14 V, V <sub>DS</sub> = 0 V)	I <sub>GSS</sub>	- -	- ±22	±10 -	μA

### ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage (Note 3) (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 100 μA) Threshold Temperature Coefficient (Negative)	V <sub>GS(th)</sub>	1.3 -	1.75 -4.5	2.5 -	V mV/°C
Static Drain-to-Source On-Resistance (Note 3) (V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 1.5 A) (V <sub>GS</sub> = 3.5 V, I <sub>D</sub> = 0.6 A) (V <sub>GS</sub> = 3.0 V, I <sub>D</sub> = 0.2 A) (V <sub>GS</sub> = 12 V, I <sub>D</sub> = 9.0 A) (V <sub>GS</sub> = 12 V, I <sub>D</sub> = 12 A)	R <sub>DS(on)</sub>	- - - 70 67	153 175 - 90 95	181 364 1210 - -	mΩ
Forward Transconductance (Note 3) (V <sub>DS</sub> = 15 V, I <sub>D</sub> = 9.0 A)	g <sub>FS</sub>	-	24	-	Mhos

### DYNAMIC CHARACTERISTICS

Input Capacitance	(V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 10 kHz)	C <sub>iss</sub>	-	155	250	pF
Output Capacitance		C <sub>oss</sub>	-	60	100	
Transfer Capacitance		C <sub>rss</sub>	-	25	40	
Input Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 10 kHz)	C <sub>iss</sub>	-	175	-	pF
Output Capacitance		C <sub>oss</sub>	-	70	-	
Transfer Capacitance		C <sub>rss</sub>	-	30	-	

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

# NID9N05CL, NID9N05ACL

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit	
<b>SWITCHING CHARACTERISTICS (Note 4)</b>						
Turn-On Delay Time	$(V_{GS} = 10\text{ V}, V_{DD} = 40\text{ V}, I_D = 9.0\text{ A}, R_G = 9.0\ \Omega)$	$t_{d(on)}$	-	130	200	ns
Rise Time		$t_r$	-	500	750	
Turn-Off Delay Time		$t_{d(off)}$	-	1300	2000	
Fall Time		$t_f$	-	1150	1850	
Turn-On Delay Time	$(V_{GS} = 10\text{ V}, V_{DD} = 15\text{ V}, I_D = 1.5\text{ A}, R_G = 2\text{ k}\Omega)$	$t_{d(on)}$	-	200	-	ns
Rise Time		$t_r$	-	500	-	
Turn-Off Delay Time		$t_{d(off)}$	-	2500	-	
Fall Time		$t_f$	-	1800	-	
Turn-On Delay Time	$(V_{GS} = 10\text{ V}, V_{DD} = 15\text{ V}, I_D = 1.5\text{ A}, R_G = 50\ \Omega)$	$t_{d(on)}$	-	120	-	ns
Rise Time		$t_r$	-	275	-	
Turn-Off Delay Time		$t_{d(off)}$	-	1600	-	
Fall Time		$t_f$	-	1100	-	
Gate Charge	$(V_{GS} = 4.5\text{ V}, V_{DS} = 40\text{ V}, I_D = 9.0\text{ A})$ (Note 3)	$Q_T$	-	4.5	7.0	nC
		$Q_1$	-	1.2	-	
		$Q_2$	-	2.7	-	
Gate Charge	$(V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V}, I_D = 1.5\text{ A})$ (Note 3)	$Q_T$	-	3.6	-	nC
		$Q_1$	-	1.0	-	
		$Q_2$	-	2.0	-	

## SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage	$(I_S = 4.5\text{ A}, V_{GS} = 0\text{ V})$ (Note 3) $(I_S = 4.0\text{ A}, V_{GS} = 0\text{ V})$ $(I_S = 4.5\text{ A}, V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C})$	$V_{SD}$	-	0.86 0.845 0.725	1.2 - -	V
Reverse Recovery Time	$(I_S = 4.5\text{ A}, V_{GS} = 0\text{ V}, di_S/dt = 100\text{ A}/\mu\text{s})$ (Note 3)	$t_{rr}$	-	700	-	ns
		$t_a$	-	200	-	
		$t_b$	-	500	-	
Reverse Recovery Stored Charge		$Q_{RR}$	-	6.5	-	$\mu\text{C}$

## ESD CHARACTERISTICS

Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	5000	-	-	V
	Machine Model (MM)		500	-	-	

- Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
- Switching characteristics are independent of operating junction temperatures.

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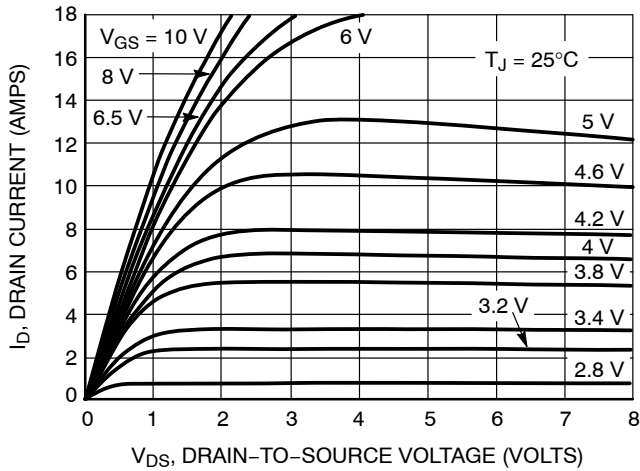


Figure 1. On-Region Characteristics

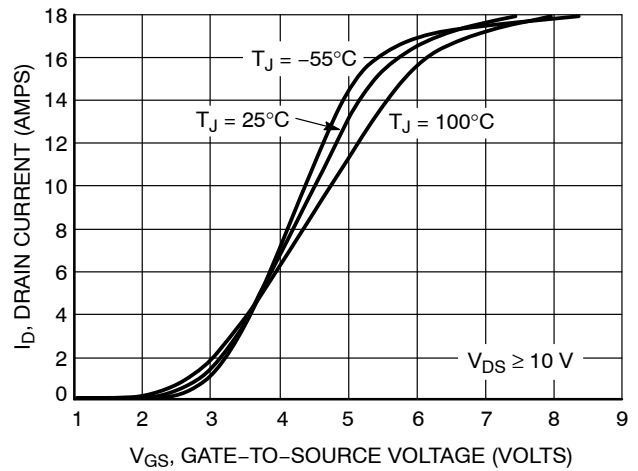


Figure 2. Transfer Characteristics

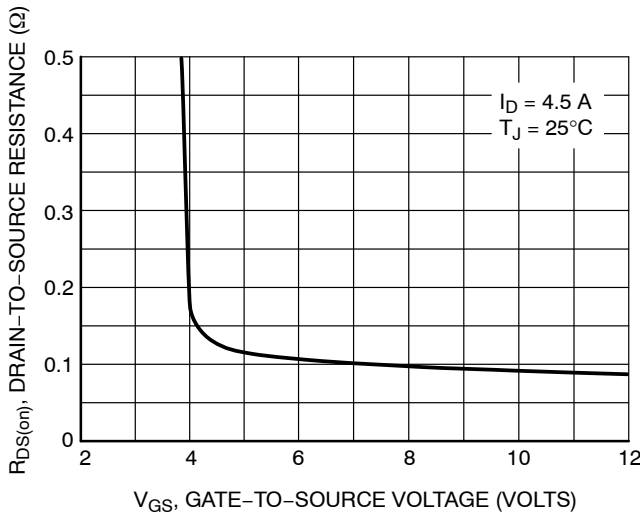


Figure 3. On-Resistance versus Gate-to-Source Voltage

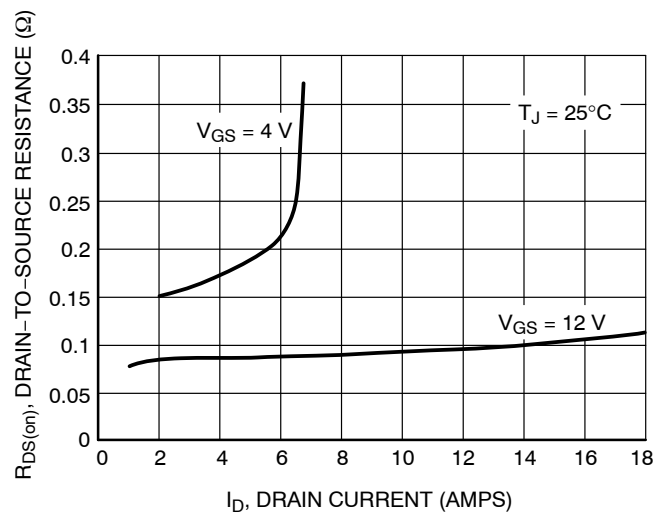


Figure 4. On-Resistance versus Drain Current and Gate Voltage

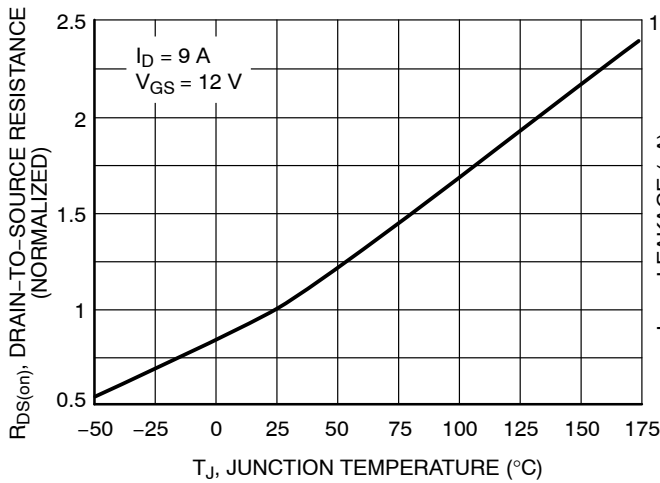


Figure 5. On-Resistance Variation with Temperature

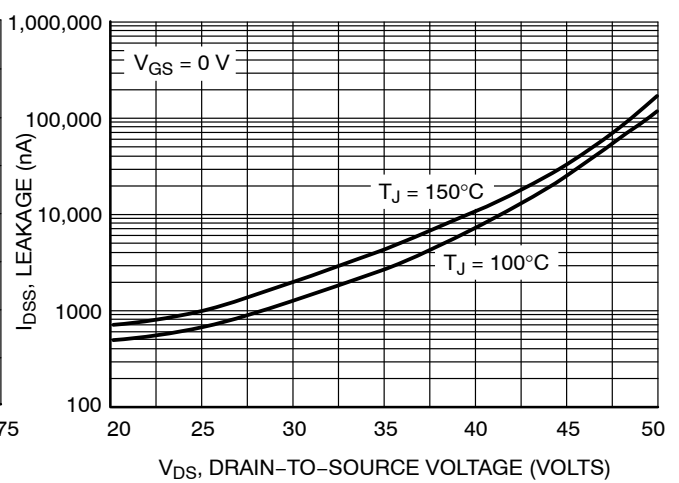


Figure 6. Drain-to-Source Leakage Current versus Voltage

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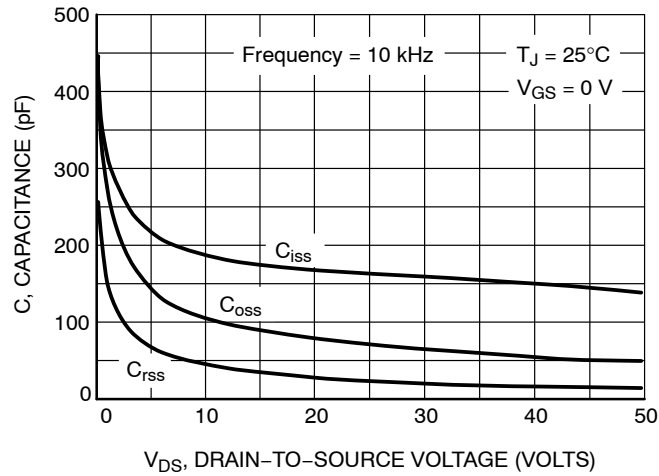


Figure 7. Capacitance Variation

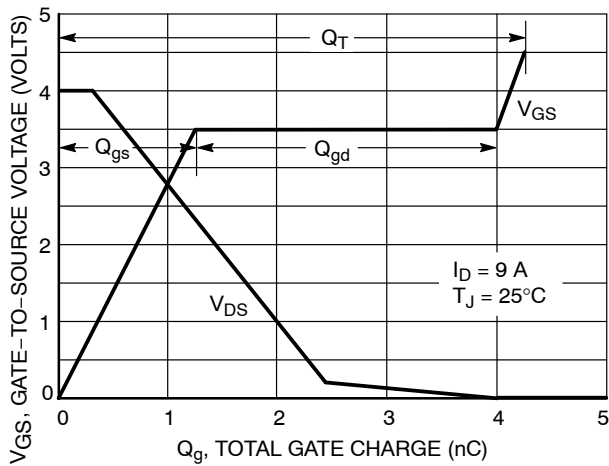


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

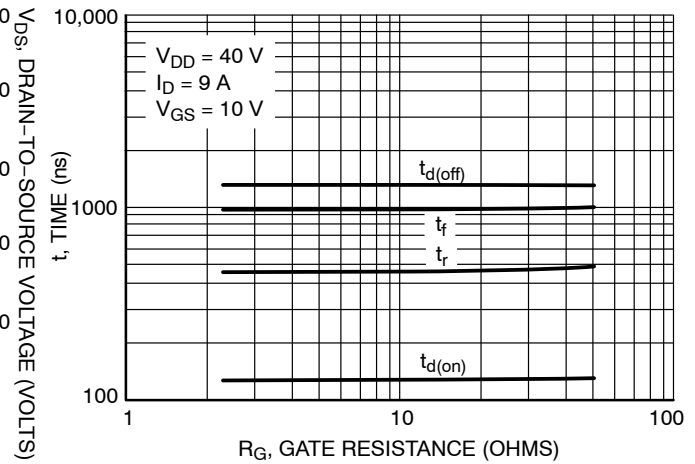


Figure 9. Resistive Switching Time Variation versus Gate Resistance

## DRAIN-TO-SOURCE DIODE CHARACTERISTICS

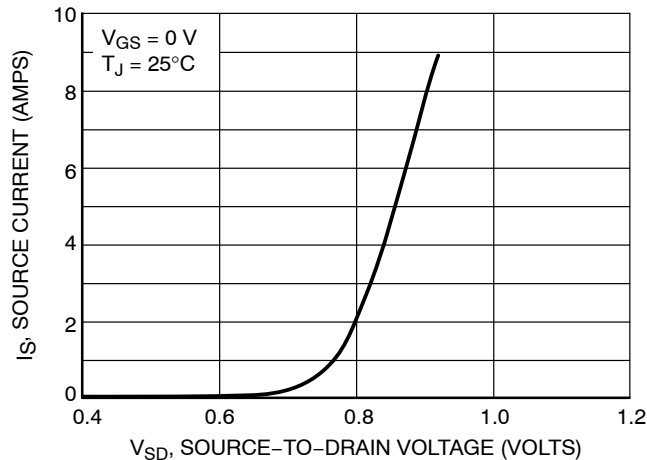


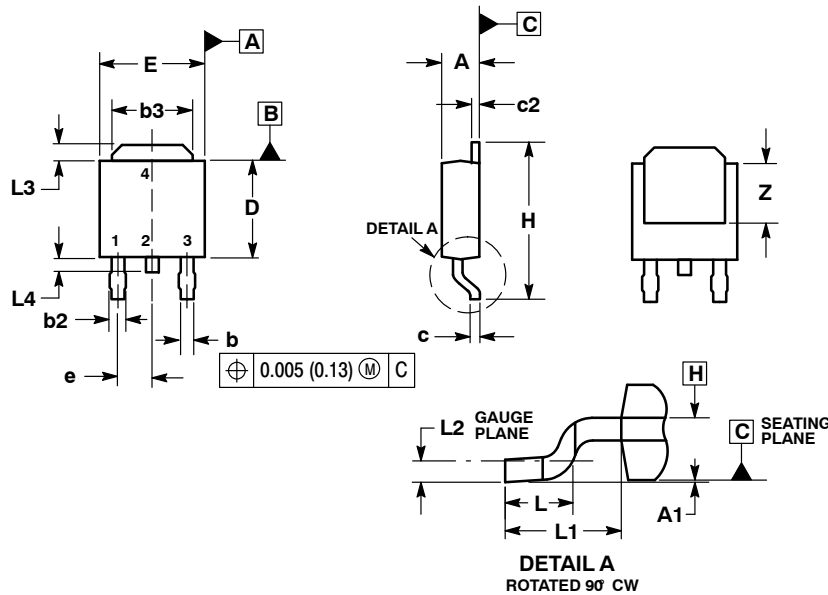
Figure 10. Diode Forward Voltage versus Current



# NID9N05CL, NID9N05ACL

## PACKAGE DIMENSIONS

### DPAK (SINGLE GAUGE) CASE 369C ISSUE D



#### NOTES:

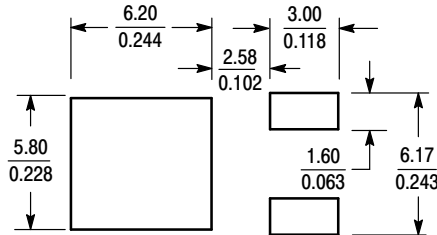
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: INCHES.
3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
e	0.090 BSC		2.29 BSC	
H	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4	---	0.040	---	1.01
Z	0.155	---	3.93	---

#### STYLE 2:

1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

#### SOLDERING FOOTPRINT\*



SCALE 3:1  $\left(\frac{\text{mm}}{\text{inches}}\right)$

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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